



FSQ0365RN, FSQ0265RN, FSQ0165RN, FSQ311 Green Mode Fairchild Power Switch (FPS™) for Quasi-Resonant Operation - Low EMI and High Efficiency

Features

- Optimized for Quasi-Resonant Converter (QRC)
- Low EMI through Variable Frequency Control and Inherent Frequency Modulation
- High-Efficiency through Minimum Voltage Switching
- Narrow Frequency Variation Range over Wide Load and Input Voltage Variation
- Advanced Burst-Mode Operation for Low Standby Power Consumption
- Pulse-by-Pulse Current Limit
- Various Protection Functions: Overload Protection (OLP), Over-Voltage Protection (OVP), Abnormal Over-Current Protection (AOCP), Internal Thermal Shutdown (TSD)
- Under-Voltage Lockout (UVLO) with Hysteresis
- Internal Start-up Circuit
- Internal High-Voltage Sense FET (650V)
- Built-in Soft-Start (15ms)

Description

A Quasi-Resonant Converter (QRC) generally shows lower EMI and higher power conversion efficiency than a conventional hard-switched converter with a fixed switching frequency. The FSQ-series is an integrated Pulse-Width Modulation (PWM) controller and SenseFET specifically designed for quasi-resonant operation with minimal external components. The PWM controller includes an integrated fixed-frequency oscillator, Under-Voltage Lockout, Leading Edge Blanking (LEB), optimized gate driver, internal soft-start, temperature-compensated precise current sources for loop compensation, and self-protection circuitry. Compared with discrete MOSFET and PWM controller solution, the FSQ-series can reduce total cost, component count, size and weight; while simultaneously increasing efficiency, productivity, and system reliability. This device provides a basic platform that is well suited for cost-effective designs of quasi-resonant switching fly-back converters.

Applications

- Power Supply for DVP Player and DVD Recorder
- Power supply for Set-Top Box
- Adapter
- Auxiliary Power Supply for PC, LCD TV, and PDP TV

Ordering Information

Product Number ⁽⁵⁾	PKG.	Operating Temp.	Current Limit	R _{DS(ON)} Max.	Maximum Output Power ⁽¹⁾				Replaces Devices
					230V _{AC} ±15% ⁽²⁾		85-265V _{AC}		
					Adapter ⁽³⁾	Open Frame ⁽⁴⁾	Adapter ⁽³⁾	Open Frame ⁽⁴⁾	
FSQ311	8-DIP	-25 to +85°C	0.6A	19Ω	7W	10W	6W	8W	FSDL321 FSDM311
FSQ0165RN	8-DIP	-25 to +85°C	0.9A	10Ω	10W	15W	9W	13W	FSDL0165RN
FSQ0265RN	8-DIP	-25 to +85°C	1.2A	6Ω	14W	20W	11W	16W	FSDM0265RN FSDM0265RNB
FSQ0365RN	8-DIP	-25 to +85°C	1.5A	4.5Ω	17.5W	25W	13W	19W	FSDM0365RN RSDM0365RNB

Notes:

1. The junction temperature can limit the maximum output power.
2. 230VAC or 100/115VAC with doubler. The maximum power with CCM operation.
3. Typical continuous power in a non-ventilated enclosed adapter measured at 50°C ambient temperature.
4. Maximum practical continuous power in an open frame design at 50°C ambient.
5. PB-free package per JEDEC J-STD-020B.

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Application Diagram

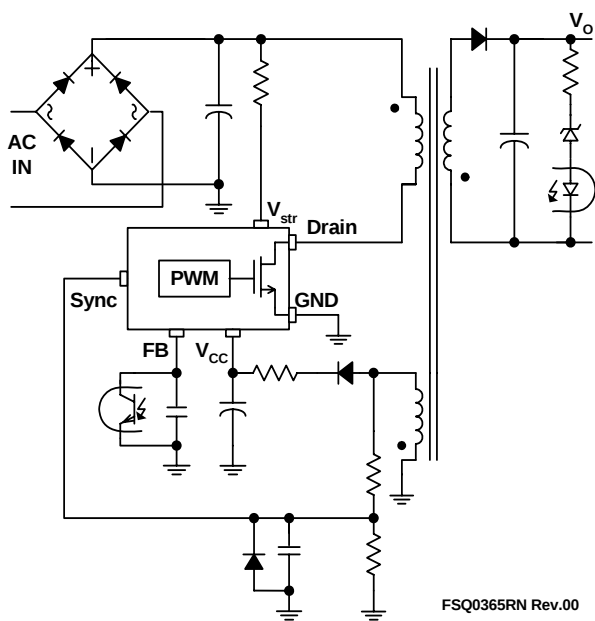


Figure 1. Typical Flyback Application

Internal Block Diagram

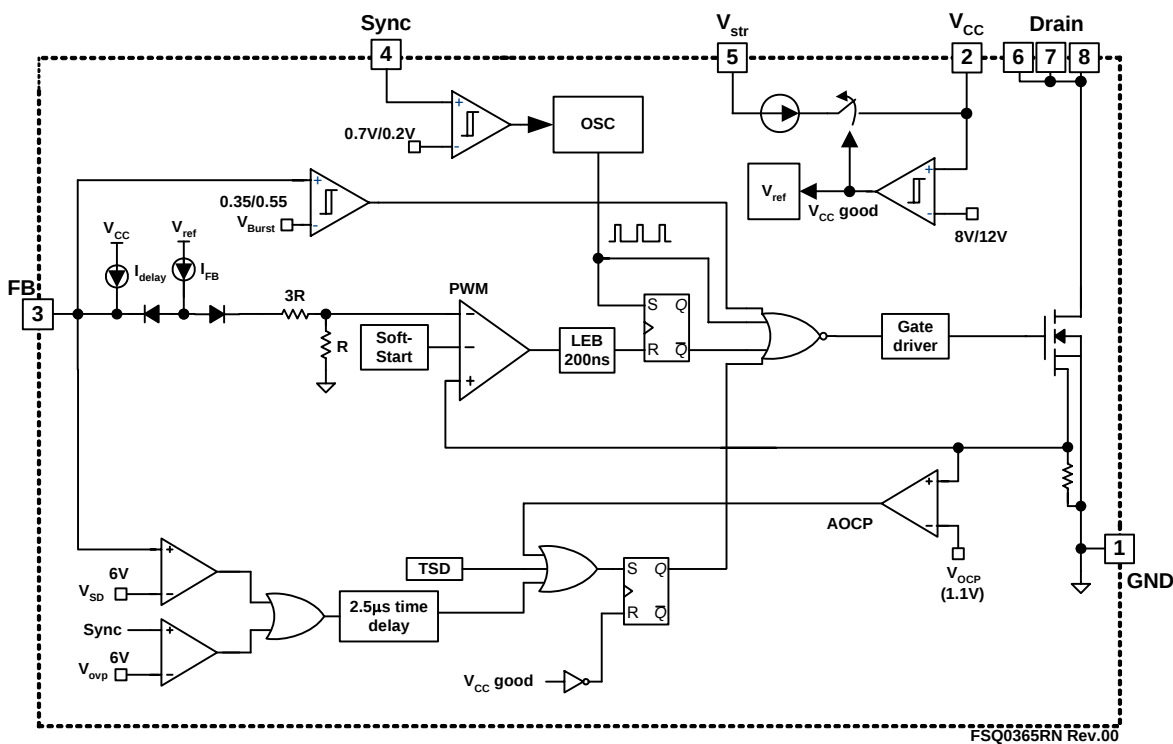


Figure 2. Internal Block Diagram

Pin Configuration

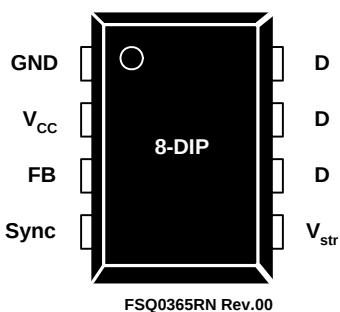


Figure 3. Pin Configuration (Top View)

Pin Definitions

Pin #	Name	Description
1	GND	Ground. This pin is the control ground and the SenseFET source.
2	V _{CC}	Power Supply. This pin is the positive supply input. This pin provides internal operating current for both start-up and steady-state operation.
3	FB	Feedback. This pin is internally connected to the inverting input of the PWM comparator. The collector of an opto-coupler is typically tied to this pin. For stable operation, a capacitor should be placed between this pin and GND. If the voltage of this pin reaches 6V, the overload protection triggers, which shuts down the FPS.
4	Sync	Sync. This pin is internally connected to the sync-detect comparator for quasi-resonant switching. In normal quasi-resonant operation, the threshold of the sync comparator is 0.7V/0.2V.
5	V _{str}	Start-up. This pin is connected directly to the high-voltage DC link. At start-up, the internal high-voltage current source supplies internal bias and charges the external capacitor connected to the V _{CC} pin. Once V _{CC} reaches 12V, the internal current source is disabled.
6	Drain	SenseFET drain. High-voltage power SenseFET drain connection.
7	Drain	SenseFET drain. High-voltage power SenseFET drain connection.
8	Drain	SenseFET drain. High-voltage power SenseFET drain connection.

Absolute Maximum Ratings

The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings. $T_A = 25^\circ\text{C}$, unless otherwise specified.

Symbol	Parameter		Min.	Max.	Unit
V_{str}	V_{str} Pin Voltage		500		V
V_{DS}	Drain Pin Voltage		650		V
V_{CC}	Supply Voltage			20	V
V_{FB}	Feedback Voltage Range		-0.3	9.0	V
V_{Sync}	Sync Pin Voltage		-0.3	9.0	V
I_{DM}	Drain Current Pulsed ⁽⁶⁾	FSQ0365RN		12	A
		FSQ0265RN		8	
		FSQ0165RN		4	
		FSQ311		1.5	
E_{AS}	Single Pulsed Avalanche Energy ⁽⁷⁾	FSQ0365RN		230	mJ
		FSQ0265RN		140	
		FSQ0165RN		50	
		FSQ311		10	
P_D	Total Power Dissipation			1.5	W
T_J	Operating Junction Temperature		Internally limited		$^\circ\text{C}$
T_A	Operating Ambient Temperature		-25	85	$^\circ\text{C}$
T_{STG}	Storage Temperature		-55	150	$^\circ\text{C}$
	ESD Capability, HBM Model ⁽⁸⁾		CLASS1 C		
	ESD Capability, Machine Model ⁽⁸⁾		CLASS B		

Notes:

6. Repetitive rating: Pulse width limited by maximum junction temperature.
7. $L=14\text{mH}$, starting $T_J=25^\circ\text{C}$.
8. Meets JEDEC Standards JESD 22-A114 and 22-A115.

Thermal Impedance⁽⁹⁾

Symbol	Parameter	Value	Unit
8-DIP			
$\theta_{JA}^{(10)}$	Junction-to-Ambient Thermal Resistance	80	$^\circ\text{C/W}$
$\theta_{JC}^{(11)}$	Junction-to-Case Thermal Resistance	20	
$\theta_{JT}^{(12)}$	Junction-to-Top Thermal Resistance	35	

Notes:

9. All items are tested with the standards JESD 51-2 and 51-10 (DIP).
10. Free-standing, with no heat-sink, under natural convection.
11. Infinite cooling condition - refer to the SEMI G30-88.
12. Measured on the PKG top surface.

Electrical Characteristics

T_A = 25°C unless otherwise specified.

Symbol	Parameter		Condition	Min.	Typ.	Max.	Unit
SENSEFET SECTION							
BV _{DSS}	Drain Source Breakdown Voltage		V _{CC} = 0V, I _D = 100μA	650			V
I _{DSS}	Zero-Gate-Voltage Drain Current		V _{DS} = 560V			100	μA
R _{DS(ON)}	Drain-Source on-State Resistance	FSQ0365RN	T _J = 25°C, I _D = 0.5A		3.5	4.5	Ω
		FSQ0265RN			5.0	6.0	
		FSQ0165RN			8.0	10.0	
		FSQ311			14.0	19.0	
C _{SS}	Input Capacitance	FSQ0365RN	V _{GS} = 0V, V _{DS} = 25V, f = 1MHz		315		pF
		FSQ0265RN			550		
		FSQ0165RN			250		
		FSQ311			162		
C _{OSS}	Output Capacitance	FSQ0365RN	V _{GS} = 0V, V _{DS} = 25V, f = 1MHz		47		pF
		FSQ0265RN			38		
		FSQ0165RN			25		
		FSQ311			18		
C _{RSS}	Reverse Transfer Capacitance	FSQ0365RN	V _{GS} = 0V, V _{DS} = 25V, f = 1MHz		9.0		pF
		FSQ0265RN			17.0		
		FSQ0165RN			10.0		
		FSQ311			3.8		
t _{d(on)}	Turn-On Delay Time	FSQ0365RN	V _{DD} = 350V, I _D = 25mA		11.2		ns
		FSQ0265RN			20.0		
		FSQ0165RN			12.0		
		FSQ311			9.5		
t _r	Rise Time	FSQ0365RN	V _{DD} = 350V, I _D = 25mA		34		ns
		FSQ0265RN			15		
		FSQ0165RN			4		
		FSQ311			19		
t _{d(off)}	Turn-Off Delay Time	FSQ0365RN	V _{DD} = 350V, I _D = 25mA		28.3		ns
		FSQ0265RN			55.0		
		FSQ0165RN			30.0		
		FSQ311			33.0		
t _f	Fall Time	FSQ0365RN	V _{DD} = 350V, I _D = 25mA		32		ns
		FSQ0265RN			25		
		FSQ0165RN			10		
		FSQ311			42		

Electrical Characteristics (Continued)

T_A = 25°C unless otherwise specified.

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit	
CONTROL SECTION							
t _{ON.MAX}	Maximum ON Time	T _J = 25°C	10.5	12.0	13.5	μsec	
t _B	Blanking Time		13.2	15.0	16.8	μsec	
t _W	Detection Time Window	T _J = 25°C, V _{sync} = 0V		3.0		μsec	
f _S	Initial Switching Frequency		50.5	55.6	61.7	kHz	
Δf _S	Switching Frequency Variation ⁽¹³⁾	-25°C < T _J < 85°C		±5	±10	%	
I _{FB}	Feedback Source Current	V _{FB} = 0V	700	900	1100	μA	
D _{MIN}	Minimum Duty Cycle	V _{FB} = 0V			0	%	
V _{START}	UVLO Threshold Voltage		11	12	13	V	
V _{STOP}		After turn-on	7	8	9	V	
t _{S/S}	Internal Soft-Start Time	With free-running frequency		15		ms	
BURST-MODE SECTION							
V _{BURH}	Burst-Mode Voltages	T _J = 25°C, t _{PD} = 200ns ⁽¹⁴⁾	0.45	0.55	0.65	V	
V _{BURL}			0.25	0.35	0.45	V	
Hysteresis				200		mV	
PROTECTION SECTION							
I _{LIMIT}	Peak Current Limit	FSQ0365RN	T _J = 25°C, di/dt = 240mA/μsec	1.32	1.50	1.68	A
		FSQ0265RN	T _J = 25°C, di/dt = 200mA/μsec	1.06	1.20	1.34	
		FSQ0165RN	T _J = 25°C, di/dt = 150mA/μsec	0.8	0.9	1.0	
		FSQ311	T _J = 25°C, di/dt = 100mA/μsec	0.53	0.60	0.67	
V _{SD}	Shutdown Feedback Voltage	V _{CC} = 15V	5.5	6.0	6.5	V	
I _{DELAY}	Shutdown Delay Current	V _{FB} = 5V	4	5	6	μA	
t _{LEB}	Leading-Edge Blanking Time ⁽¹³⁾			200		ns	
V _{OVP}	Over-Voltage Protection	V _{CC} = 15V, V _{FB} = 2V	5.5	6.0	6.5	V	
t _{OVP}	Over-Voltage Protection Blanking Time		2	3	4	μsec	
T _{SD}	Thermal Shutdown Temperature ⁽¹³⁾		125	140	155	°C	
SYNC SECTION							
V _{SH}	Sync Threshold Voltage		0.55	0.70	0.85	V	
V _{SL}			0.14	0.20	0.26	V	
t _{sync}	Sync Delay Time ⁽¹³⁾⁽¹⁵⁾			300		ns	
TOTAL DEVICE SECTION							
I _{OP}	Operating Supply Current (Control Part Only)	V _{CC} = 15V	1	3	5	mA	
I _{START}	Start Current	V _{CC} = V _{START} - 0.1V (before V _{CC} reaches V _{START})	270	360	450	μA	
I _{CH}	Start-up Charging Current	V _{CC} = 0V, V _{STR} = min. 40V	0.65	0.85	1.00	mA	
V _{STR}	Minimum V _{STR} Supply Voltage			26		V	

Notes:

13. Though guaranteed, it is not tested in the mass production.
14. Propagation delay in the control IC.
15. Include gate turn-on time.

Comparison Between FSDM0x65RNB and FSQ-Series

Function	FSDM0x65RNB	FSQ-Series	FSQ-Series Advantages
Operation method	Constant frequency PWM	Quasi-resonant operation	■ Improved efficiency by valley switching ■ Reduced EMI noise
EMI reduction	Frequency modulation	Valley switching & inherent frequency modulation	■ Reduce EMI noise by two ways
Burst-mode operation	Fixed burst peak	Advanced burst-mode	■ Improved standby power by valley switching also in burst-mode ■ Because the current peak during burst operation is dependent on V_{FB}, it is easier to solve audible noise
Protection		AOCP	■ Improved reliability through precise abnormal over-current protection

Typical Performance Characteristics

These characteristic graphs are normalized at $T_A = 25^\circ\text{C}$.

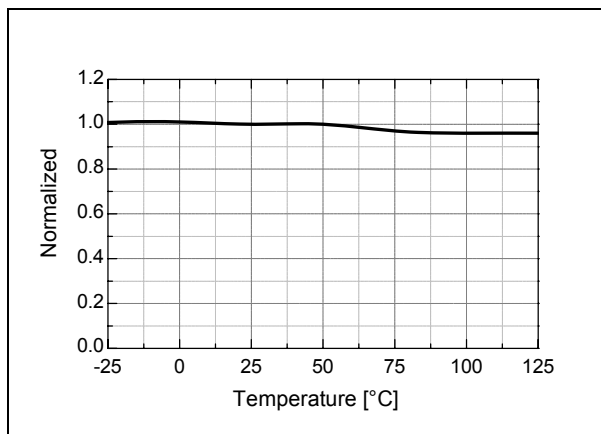


Figure 4. Operating Supply Current (I_{OP}) vs. T_A

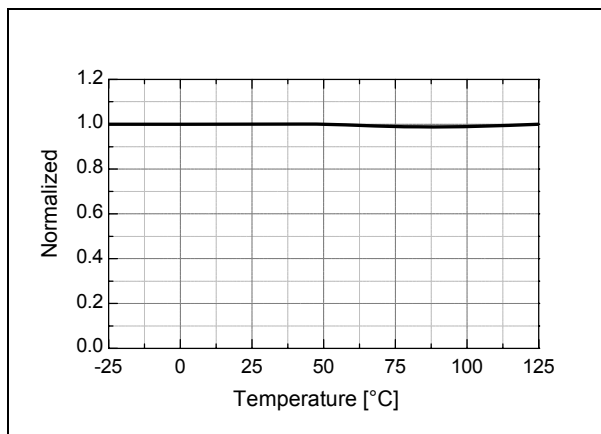


Figure 5. UVLO Start Threshold Voltage (V_{START}) vs. T_A

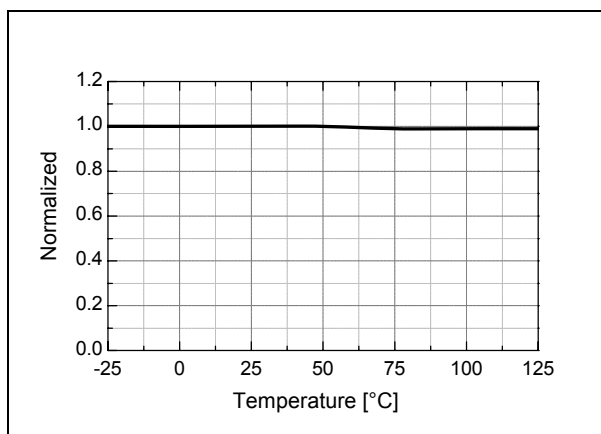


Figure 6. UVLO Stop Threshold Voltage (V_{STOP}) vs. T_A

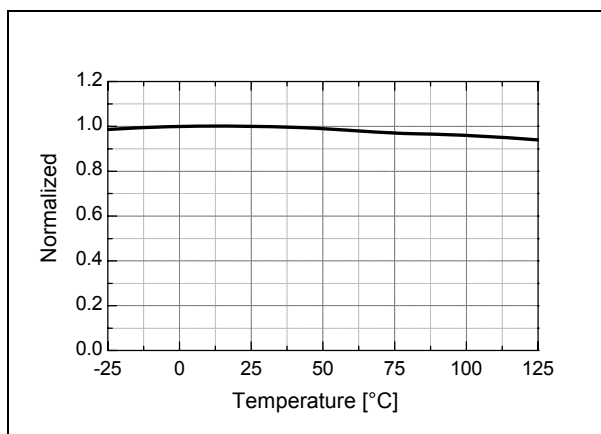


Figure 7. Start-up Charging Current (I_{CH}) vs. T_A

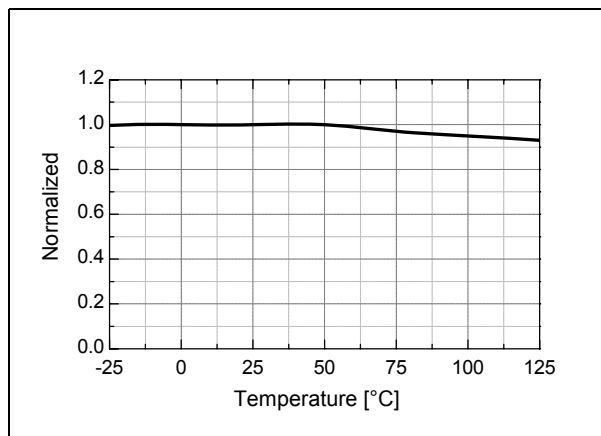


Figure 8. Initial Switching Frequency (f_S) vs. T_A

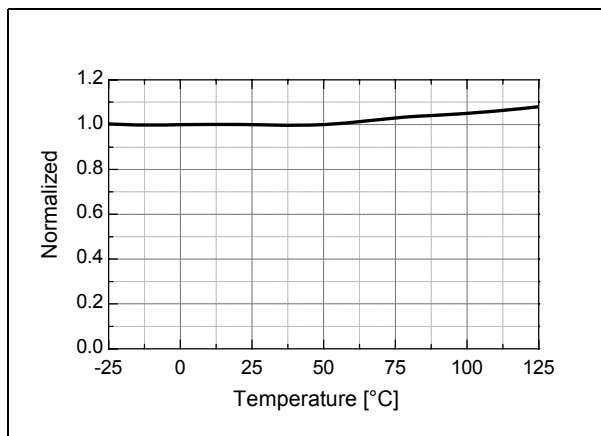


Figure 9. Maximum On Time ($t_{ON.MAX}$) vs. T_A

Typical Performance Characteristics (Continued)

These characteristic graphs are normalized at $T_A = 25^\circ\text{C}$.

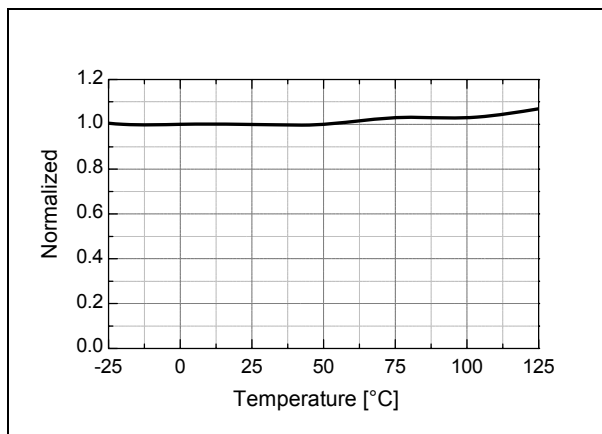


Figure 10. Blanking Time (t_B) vs. T_A

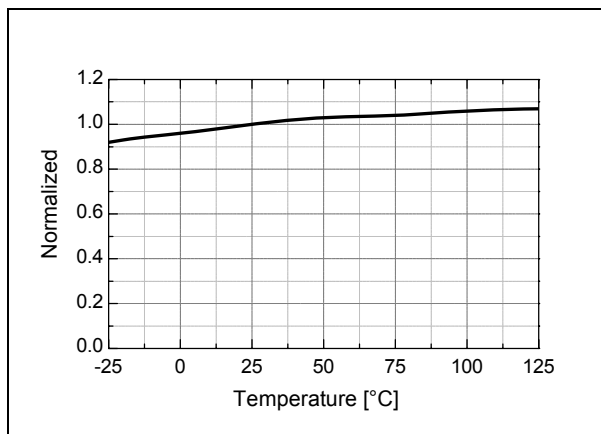


Figure 11. Feedback Source Current (I_{FB}) vs. T_A

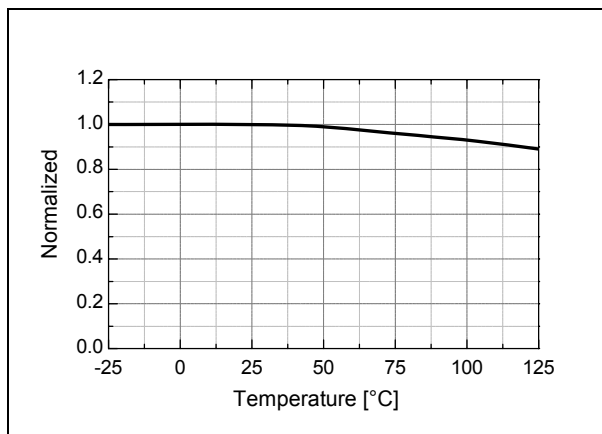


Figure 12. Shutdown Delay Current (I_{DELAY}) vs. T_A

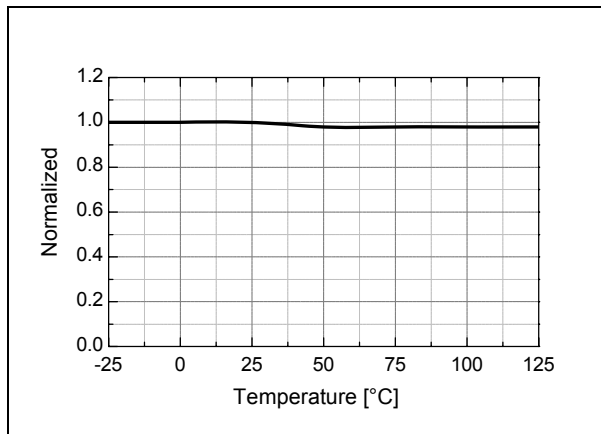


Figure 13. Burst-Mode High Threshold Voltage (V_{burh}) vs. T_A

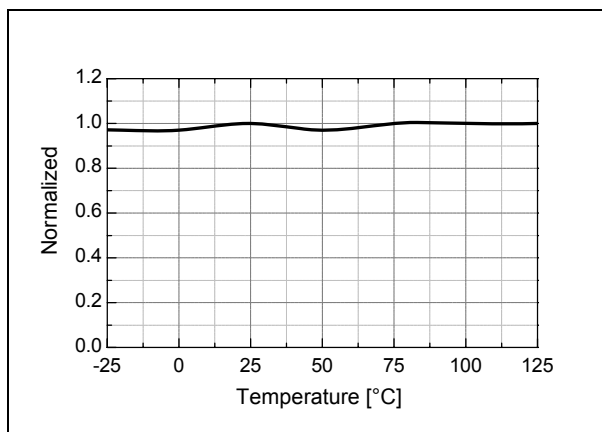


Figure 14. Burst-Mode Low Threshold Voltage (V_{burl}) vs. T_A

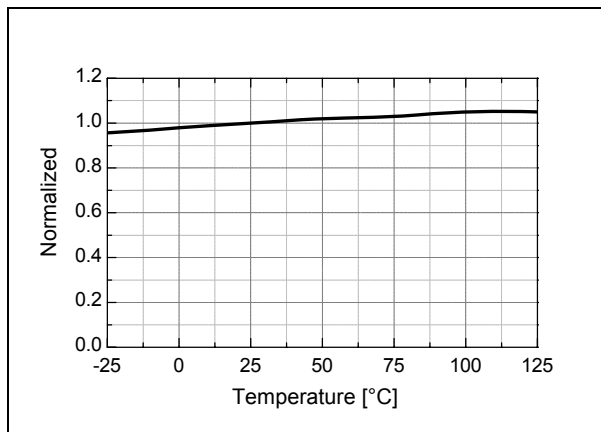


Figure 15. Peak Current Limit (I_{LIM}) vs. T_A

Typical Performance Characteristics (Continued)

These characteristic graphs are normalized at $T_A = 25^\circ\text{C}$.

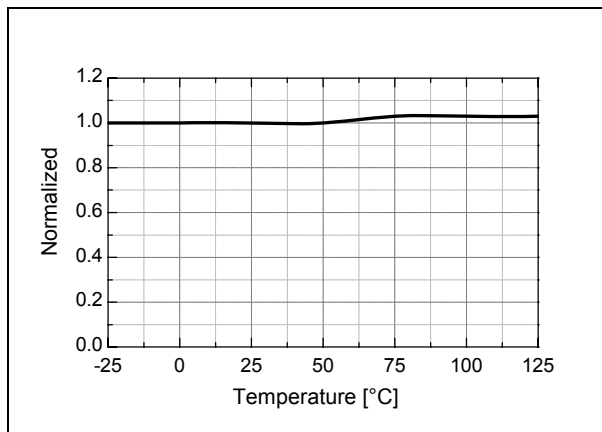


Figure 16. Sync High Threshold Voltage (V_{SH}) vs. T_A

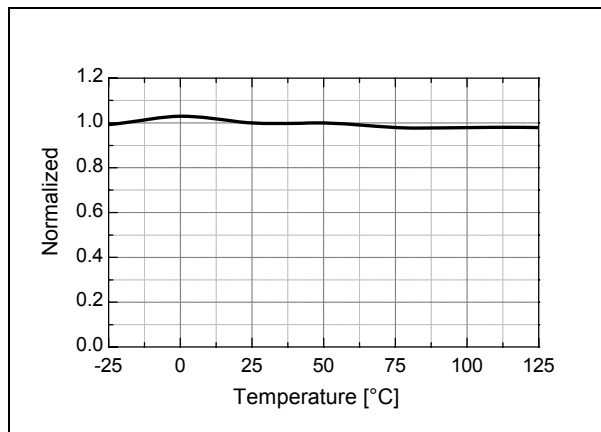


Figure 17. Sync Low Threshold Voltage (V_{SL}) vs. T_A

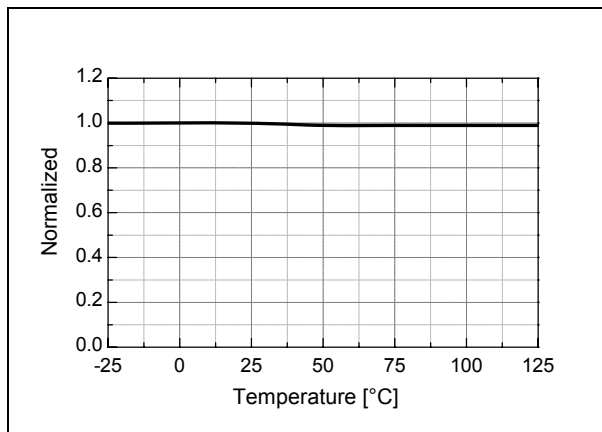


Figure 18. Shutdown Feedback Voltage (V_{SD}) vs. T_A

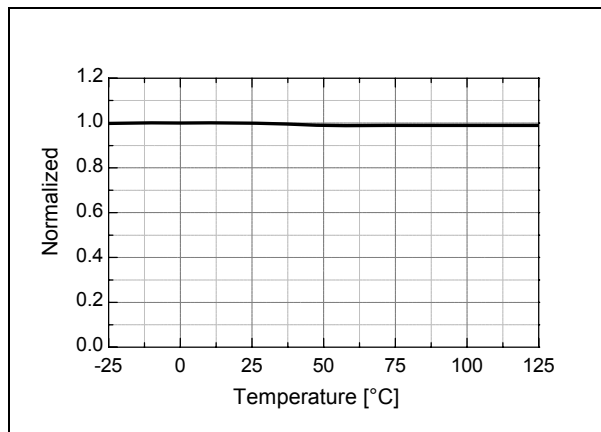


Figure 19. Over-Voltage Protection (V_{OV}) vs. T_A

Functional Description

1. Startup: At startup, an internal high-voltage current source supplies the internal bias and charges the external capacitor (C_a) connected to the V_{CC} pin, as illustrated in Figure 20. When V_{CC} reaches 12V, the FPS begins switching and the internal high-voltage current source is disabled. The FPS continues its normal switching operation and the power is supplied from the auxiliary transformer winding unless V_{CC} goes below the stop voltage of 8V.

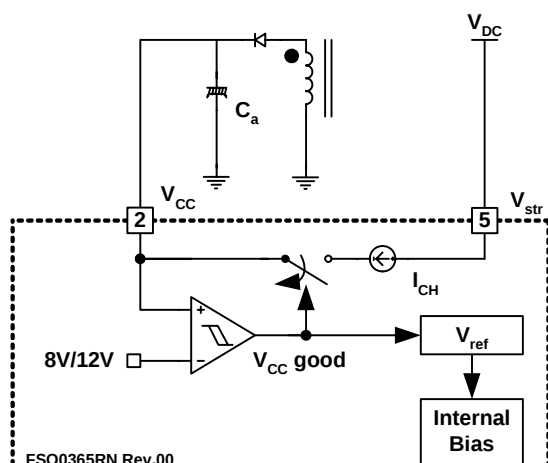


Figure 20. Start-up Circuit

2. Feedback Control: FPS employs current mode control, as shown in Figure 21. An opto-coupler (such as the FOD817A) and shunt regulator (such as the KA431) are typically used to implement the feedback network. Comparing the feedback voltage with the voltage across the R_{sense} resistor makes it possible to control the switching duty cycle. When the reference pin voltage of the shunt regulator exceeds the internal reference voltage of 2.5V, the opto-coupler LED current increases, thus pulling down the feedback voltage and reducing the duty cycle. This event typically happens when the input voltage is increased or the output load is decreased.

2.1 Pulse-by-Pulse Current Limit: Because current mode control is employed, the peak current through the SenseFET is limited by the inverting input of PWM comparator (V_{FB}^*), as shown in Figure 21. Assuming that the 0.9mA current source flows only through the internal resistor ($3R + R = 2.8k$), the cathode voltage of diode D2 is about 2.5V. Since D1 is blocked when the feedback voltage (V_{FB}) exceeds 2.5V, the maximum voltage of the cathode of D2 is clamped at this voltage, thus clamping V_{FB}^* . Therefore, the peak value of the current through the SenseFET is limited.

2.2 Leading Edge Blanking (LEB): At the instant the internal SenseFET is turned on, a high-current spike usually occurs through the SenseFET, caused by primary-side capacitance and secondary-side rectifier reverse recovery. Excessive voltage across the R_{sense} resistor would lead to incorrect feedback operation in the current mode PWM control. To counter this effect, the FPS employs a leading edge blanking (LEB) circuit. This circuit inhibits the PWM comparator for a short time (t_{LEB}) after the SenseFET is turned on.

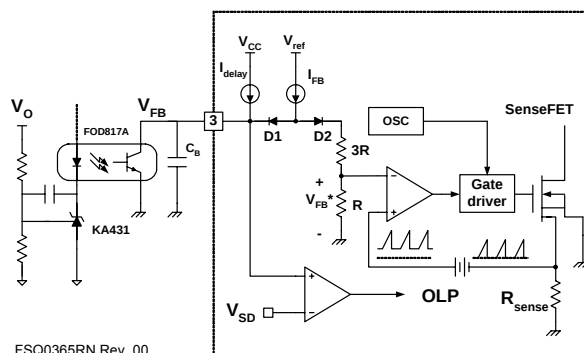


Figure 21. Pulse-Width-Modulation (PWM) Circuit

3. Synchronization: The FSQ-series employs a quasi-resonant switching technique to minimize the switching noise and loss. The basic waveforms of the quasi-resonant converter are shown in Figure 22. To minimize the MOSFET's switching loss, the MOSFET should be turned on when the drain voltage reaches its minimum value, as shown in Figure 22. The minimum drain voltage is indirectly detected by monitoring the V_{CC} winding voltage, as shown in Figure 22.

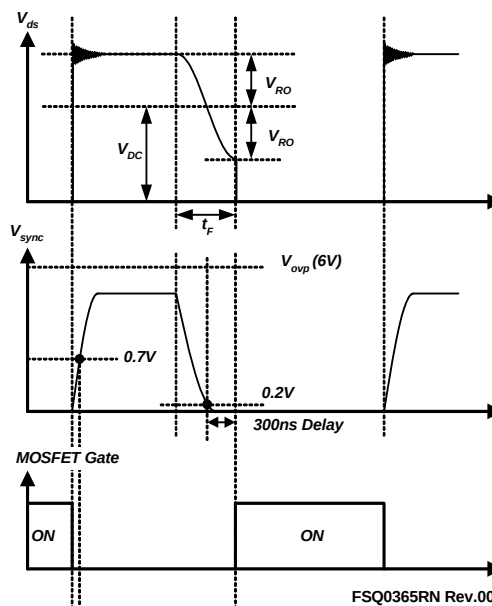


Figure 22. Quasi-Resonant Switching Waveforms

4. Protection Circuits: The FSQ-series has several self-protective functions, such as Overload Protection (OLP), Abnormal Over-Current protection (AOCP), Over-Voltage Protection (OVP), and Thermal Shutdown (TSD). All the protections are implemented as auto-restart mode. Once the fault condition is detected, switching is terminated and the SenseFET remains off. This causes V_{CC} to fall. When V_{CC} falls down to the Under-Voltage Lockout (UVLO) stop voltage of 8V, the protection is reset and start-up circuit charges V_{CC} capacitor. When the V_{CC} reaches the start voltage of 12V, the FSQ-series resumes normal operation. If the fault condition is not removed, the SenseFET remains off and V_{CC} drops to stop voltage again. In this manner, the auto-restart can alternately enable and disable the switching of the power SenseFET until the fault condition is eliminated. Because these protection circuits are fully integrated into the IC without external components, the reliability is improved without increasing cost.

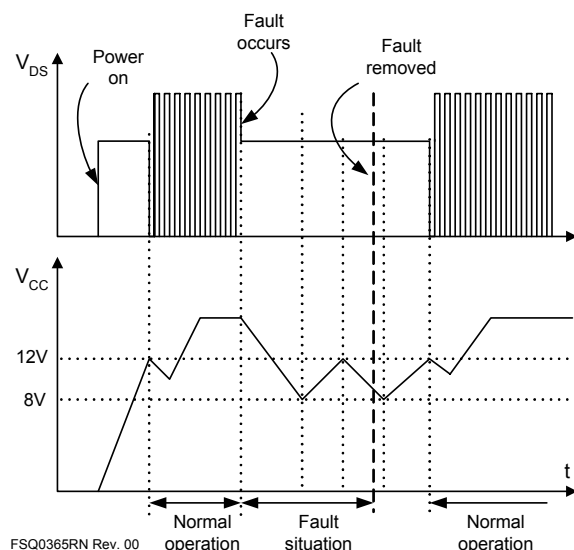


Figure 23. Auto Restart Protection Waveforms

4.1 Overload Protection (OLP): Overload is defined as the load current exceeding its normal level due to an unexpected abnormal event. In this situation, the protection circuit should trigger to protect the SMPS. However, even when the SMPS is in the normal operation, the overload protection circuit can be triggered during the load transition. To avoid this undesired operation, the overload protection circuit is designed to trigger only after a specified time to determine whether it is a transient situation or a true overload situation. Because of the pulse-by-pulse current limit capability, the maximum peak current through the Sense FET is limited, and therefore the maximum input power is restricted with a given input

voltage. If the output consumes more than this maximum power, the output voltage (V_O) decreases below the set voltage. This reduces the current through the opto-coupler LED, which also reduces the opto-coupler transistor current, thus increasing the feedback voltage (V_{FB}). If V_{FB} exceeds 2.8V, D1 is blocked and the 5 μ A current source starts to charge CB slowly up to V_{CC} . In this condition, V_{FB} continues increasing until it reaches 6V, when the switching operation is terminated, as shown in Figure 24. The delay time for shutdown is the time required to charge CB from 2.8V to 6V with 5 μ A. A 20 ~ 50ms delay time is typical for most applications.

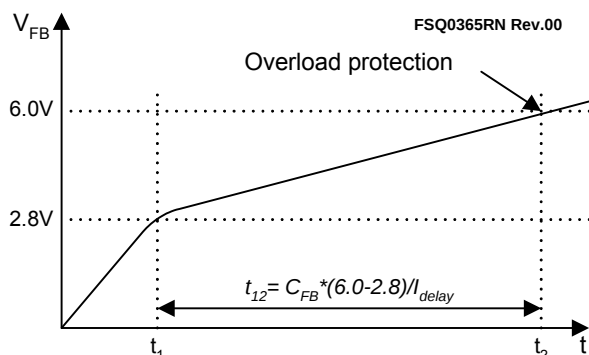


Figure 24. Overload Protection

4.2 Abnormal Over-Current Protection (AOCP): When the secondary rectifier diodes or the transformer pins are shorted, a steep current with extremely high-di/dt can flow through the SenseFET during the LEB time. Even though the FSQ-series has OLP (Overload Protection), it is not enough to protect the FSQ-series in that abnormal case, since severe current stress is imposed on the SenseFET until OLP triggers. The FSQ-series has an internal AOCP (Abnormal Over-Current Protection) circuit as shown in Figure 25. When the gate turn-on signal is applied to the power SenseFET, the AOCP block is enabled and monitors the current through the sensing resistor. The voltage across the resistor is compared with a preset AOCP level. If the sensing resistor voltage is greater than the AOCP level, the set signal is applied to the latch, resulting in the shutdown of the SMPS.

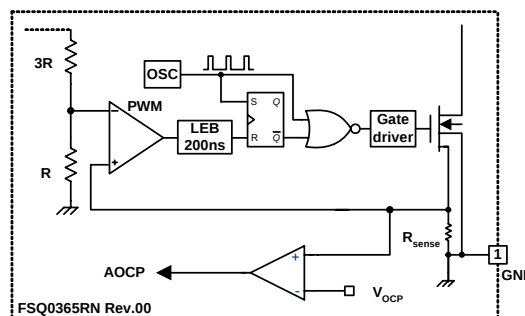


Figure 25. Abnormal Over-Current Protection

4.3 Over-Voltage Protection (OVP): If the secondary side feedback circuit malfunctions or a solder defect causes an opening in the feedback path, the current through the opto-coupler transistor becomes almost zero. Then, V_{FB} climbs up in a similar manner to the overload situation, forcing the preset maximum current to be supplied to the SMPS until the overload protection triggers. Because more energy than required is provided to the output, the output voltage may exceed the rated voltage before the overload protection triggers, resulting in the breakdown of the devices in the secondary side. To prevent this situation, an OVP circuit is employed. In general, the peak voltage of the sync signal is proportional to the output voltage and the FSQ-series uses a sync signal instead of directly monitoring the output voltage. If the sync signal exceeds 6V, an OVP is triggered, shutting down the SMPS. To avoid undesired triggering of OVP during normal operation, the peak voltage of the sync signal should be designed below 6V.

4.4 Thermal Shutdown (TSD): The SenseFET and the control IC are built in one package. This makes it easy for the control IC to detect the abnormal over temperature of the SenseFET. If the temperature exceeds $\sim 150^{\circ}\text{C}$, the thermal shutdown triggers.

5. Soft-Start: The FPS has an internal soft-start circuit that increases PWM comparator inverting input voltage with the SenseFET current slowly after it starts up. The typical soft-start time is 15ms. The pulse width to the power switching device is progressively increased to establish the correct working conditions for transformers, inductors, and capacitors. The voltage on the output capacitors is progressively increased with the intention of smoothly establishing the required output voltage. This mode helps prevent transformer saturation and reduces stress on the secondary diode during startup.

6. Burst Operation: To minimize power dissipation in standby mode, the FPS enters burst-mode operation. As the load decreases, the feedback voltage decreases. As shown in Figure 26, the device automatically enters burst-mode when the feedback voltage drops below V_{BURL} (350mV). At this point, switching stops and the output voltages start to drop at a rate dependent on standby current load. This causes the feedback voltage to rise. Once it passes V_{BURH} (550mV), switching resumes. The feedback voltage then falls and the process repeats. Burst-mode operation alternately enables and disables switching of the power SenseFET, thereby reducing switching loss in standby mode.

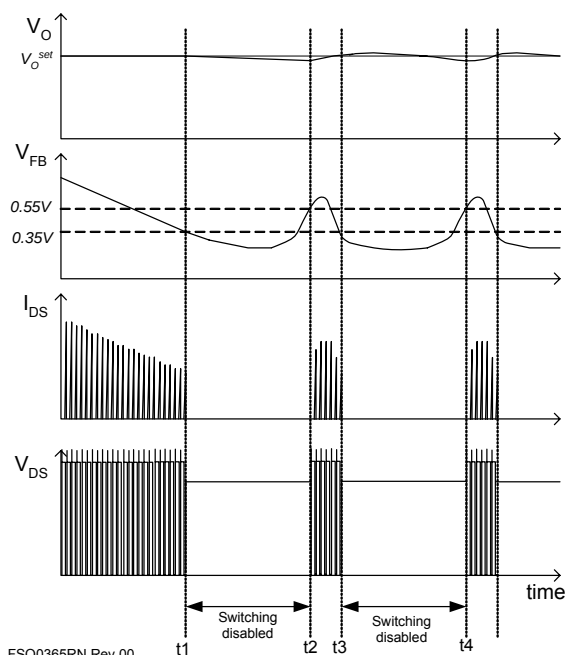


Figure 26. Waveforms of Burst Operation

7. Switching Frequency Limit: To minimize switching loss and EMI (Electromagnetic Interference), the MOSFET turns on when the drain voltage reaches its minimum value in quasi-resonant operation. However, this causes switching frequency to increase at light load conditions. As the load decreases, the peak drain current diminishes and the switching frequency increases. This results in severe switching losses at light-load condition, as well as intermittent switching and audible noise. Because of these problems, the quasi-resonant converter topology has limitations in a wide range of applications.

To overcome this problem, FSQ-series employs a frequency-limit function, as shown in Figures 27 and 28. Once the SenseFET is turned on, the next turn-on is prohibited during the blanking time (t_B). After the blanking time, the controller finds the valley within the detection time window (t_W) and turns on the MOSFET, as shown in Figures 27 and 28 (Cases A, B, and C). If no valley is found during t_W , the internal SenseFET is forced to turn on at the end of t_W (Case D). Therefore, our devices have a minimum switching frequency of 55kHz and a maximum switching frequency of 67kHz, as shown in Figure 28.

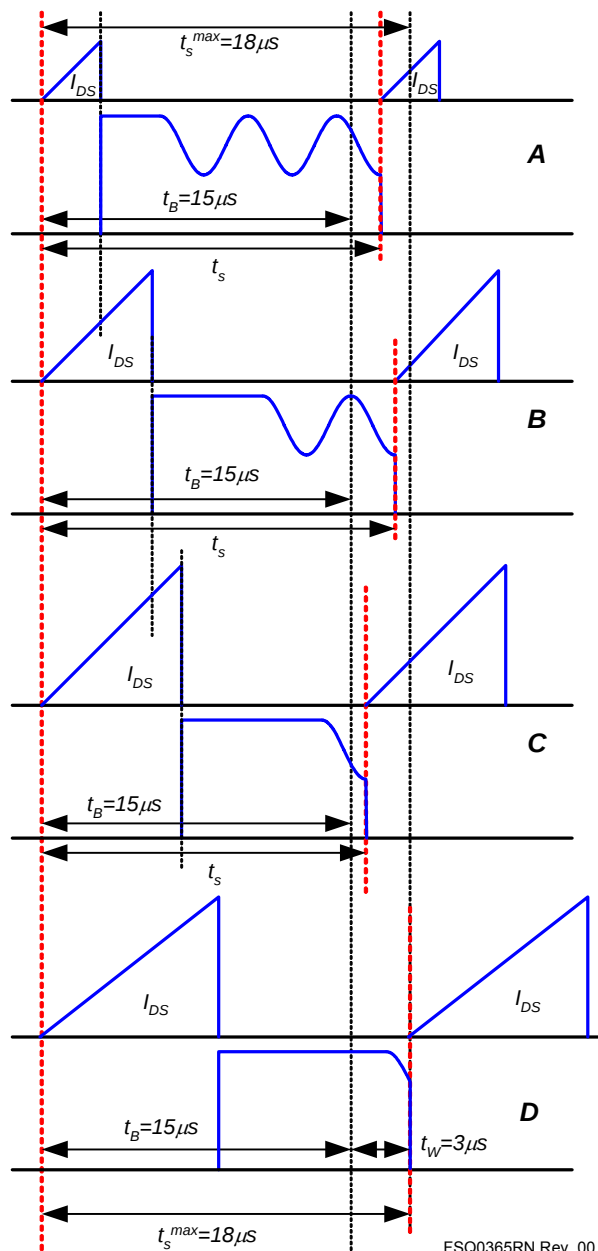


Figure 27. QRC Operation with Limited Frequency

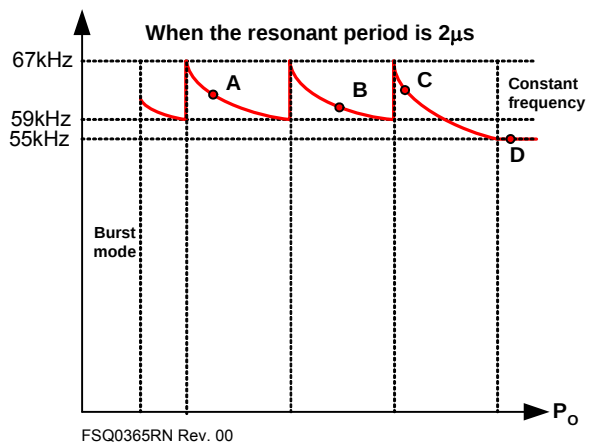


Figure 28. Switching Frequency Range

2. Transformer

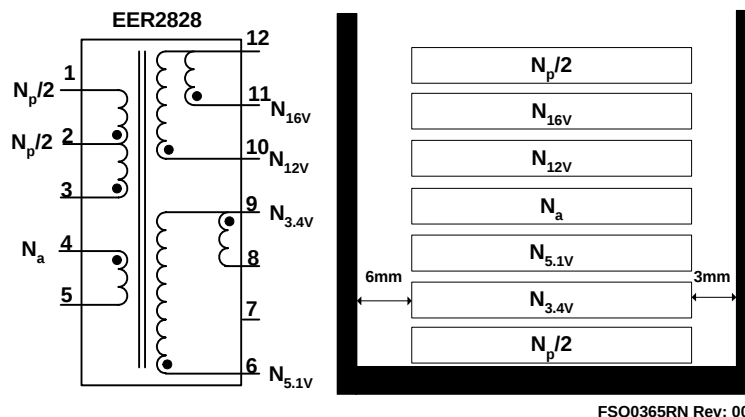


Figure 30. Transformer Schematic Diagram

3. Winding Specification

No	Pin (s→f)	Wire	Turns	Winding Method
$N_p/2$	3 → 2	$0.25^\phi \times 1$	50	Center Solenoid Winding
Insulation: Polyester Tape $t = 0.050\text{mm}$, 2 Layers				
$N_{3.4V}$	9 → 8	$0.33^\phi \times 2$	4	Center Solenoid Winding
Insulation: Polyester Tape $t = 0.050\text{mm}$, 2 Layers				
N_{5V}	6 → 9	$0.33^\phi \times 1$	2	Center Solenoid Winding
Insulation: Polyester Tape $t = 0.050\text{mm}$, 2 Layers				
N_a	4 → 5	$0.25^\phi \times 1$	16	Center Solenoid Winding
Insulation: Polyester Tape $t = 0.050\text{mm}$, 2 Layers				
N_{12V}	10 → 12	$0.33^\phi \times 3$	14	Center Solenoid Winding
Insulation: Polyester Tape $t = 0.050\text{mm}$, 3 Layers				
N_{16V}	11 → 12	$0.33^\phi \times 3$	18	Center Solenoid Winding
Insulation: Polyester Tape $t = 0.050\text{mm}$, 2 Layers				
$N_p/2$	2 → 1	$0.25^\phi \times 1$	50	Center Solenoid Winding
Insulation: Polyester Tape $t = 0.050\text{mm}$, 2 Layers				

4. Electrical Characteristics

	Pin	Specification	Remarks
Inductance	1 - 3	$1.4\text{mH} \pm 10\%$	100kHz, 1V
Leakage	1 - 3	$25\mu\text{H Max.}$	Short all other pins

5. Core & Bobbin

- Core: EER2828 ($A_e = 86.66\text{mm}^2$)
- Bobbin: EER2828

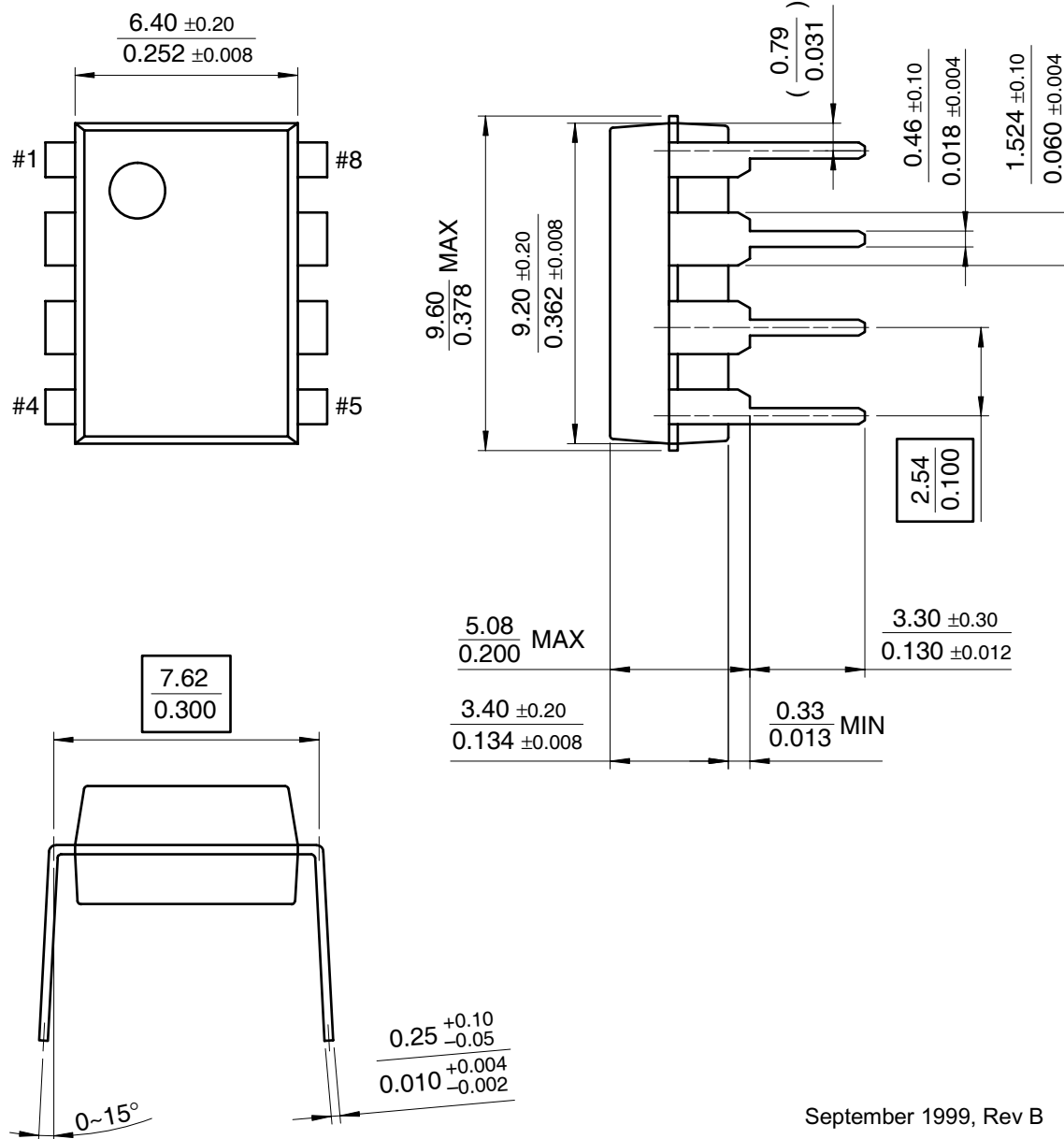
6. Demo Board Part List

Part	Value	Note	Part	Value	Note
Resistor			Inductor		
R102	56k Ω	1W	L201	10 μ H	
R103	5 Ω	1/2W	L202	10 μ H	
R104	12k Ω	1/4W	L203	4.9 μ H	
R105	100k Ω	1/4W	L204	4.9 μ H	
R106	6.2k Ω	1/4W	Diode		
R107	6.2k Ω	1/4W	D101	IN4007	
R108	62 Ω	1W	D102	IN4004	
R201	510 Ω	1/4W	ZD101	1N4746A	
R202	1k Ω	1/4W	D103	1N4148	
R203	6.2k Ω	1/4W	D201	UF4003	
R204	20k Ω	1/4W	D202	UF4003	
R205	6k Ω	1/4W	D203	SB360	
Capacitor			D204	SB360	
C101	100nF/275V _{AC}	Box Capacitor	IC		
C102	100nF/275V _{AC}	Box Capacitor	IC101	FSQ0365RN	FPS™
C103	33 μ F/400V	Electrolytic Capacitor	IC201	KA431 (TL431)	Voltage reference
C104	10nF/630V	Film Capacitor	IC202	FOD817A	Opto-coupler
C105	47nF/50V	Mono Capacitor	Fuse		
C106	100nF/50V	SMD (1206)	Fuse	2A/250V	
C107	22 μ F/50V	Electrolytic Capacitor	NTC		
C110	33pF/50V	Ceramic Capacitor	RT101	5D-9	
C201	470 μ F/35V	Electrolytic Capacitor	Bridge Diode		
C202	470 μ F/35V	Electrolytic Capacitor	BD101	2KBP06M2N257	Bridge Diode
C203	470 μ F/35V	Electrolytic Capacitor	Line Filter		
C204	470 μ F/35V	Electrolytic Capacitor	LF101	40mH	
C205	1000 μ F/10V	Electrolytic Capacitor	Transformer		
C206	1000 μ F/10V	Electrolytic Capacitor	T101		
C207	1000 μ F/10V	Electrolytic Capacitor	Varistor		
C208	1000 μ F/10V	Electrolytic Capacitor	TNR	10D471K	
C209	100nF /50V	Ceramic Capacitor			

Package Dimensions

8-DIP

Dimensions are in millimeters unless otherwise noted.



September 1999, Rev B
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FAST®	MICROWIRE™	Quiet Series™		
FASTr™	MSX™	RapidConfigure™	Across the board. Around the world.™	
FPS™	MSXPro™	RapidConnect™	Programmable Active Droop™	
FRFET™	OCX™	ScalarPump™	The Power Franchise®	

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